

## **IGBT** Module

#### SK15GD12T4ET

**Target Data** 

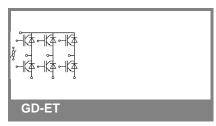
#### **Features**

- One screw mounting module
- Trench4 IGBT technology
- CAL4 technology FWD
- Integrated NTC temperature sensor

## **Typical Applications\***

### **Remarks**

• V<sub>CE,sat</sub> , V<sub>F</sub> = chip level value



<b>Absolute Maximum Ratings</b> $T_s = 25  ^{\circ}\text{C}$ , unless otherwise specified					
Symbol	Conditions			Values	Units
IGBT					•
$V_{CES}$	T <sub>j</sub> = 25 °C			1200	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C		27	Α
		$T_s = 70 ^{\circ}C$		21	Α
I <sub>CRM</sub>	I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>			45	Α
$V_{GES}$				± 20	V
t <sub>psc</sub>	$V_{CC}$ = 800 V; $V_{GE} \le 15$ V; $V_{CES} < 1200$ V	T <sub>j</sub> = 150 °C		10	μs
Inverse D	Diode				
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_s = 25 ^{\circ}C$		21	Α
		$T_s = 70  ^{\circ}C$		17	Α
$I_{\text{FRM}}$	I <sub>FRM</sub> = 3 x I <sub>Fnom</sub>			45	Α
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave	T <sub>j</sub> = 150 °C		90	Α
Module					
$I_{t(RMS)}$					Α
T <sub>vj</sub>				-40 <b>+</b> 175	°C
T <sub>stg</sub>				-40 <b>+</b> 125	°C
V <sub>isol</sub>	AC, 1 min.			2500	V

Characteristics $T_s =$			25 °C, unless otherwise specified			
Symbol	Conditions		min.	typ.	max.	Units
IGBT			•			•
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_{C} = 0.5 \text{ mA}$		5	5,8	6,5	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = V <sub>CES</sub>	T <sub>j</sub> = 25 °C			0,002	mA
		T <sub>j</sub> = 125 °C				mA
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 25 °C			120	nA
		T <sub>j</sub> = 125 °C				nA
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0,8	0,9	V
		T <sub>j</sub> = 150 °C		0,7	0,8	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		70	77	mΩ
		T <sub>j</sub> = 150°C		100	110	$m\Omega$
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 15 A, V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C <sub>chiplev</sub> .		1,85	2,05	V
		T <sub>j</sub> = 150°C <sub>chiplev.</sub>		2,25	2,45	V
C <sub>ies</sub>				0,9		nF
C <sub>oes</sub>	$V_{CE}$ = 25, $V_{GE}$ = 0 V	f = 1 MHz		0,08		nF
C <sub>res</sub>				0,055		nF
$Q_G$	V <sub>GE</sub> =-7V+15V			65		nC
t <sub>d(on)</sub>				16		ns
t <sub>r</sub>	$R_{Gon} = 16 \Omega$	V <sub>CC</sub> = 600V		14		ns
Ė <sub>on</sub>	di/dt = 2750 A/μs	I <sub>C</sub> = 15A		0,83		mJ
t <sub>d(off)</sub>	$R_{Goff} = 16 \Omega$	T <sub>j</sub> = 150 °C		273		ns
t <sub>f</sub>	di/dt = 2750 A/μs	V <sub>GE</sub> = -7+15 V		85		ns
E <sub>off</sub>				1,52		mJ
$R_{th(j-s)}$	per IGBT			1,65		K/W



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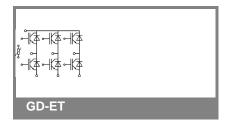
#### Remarks

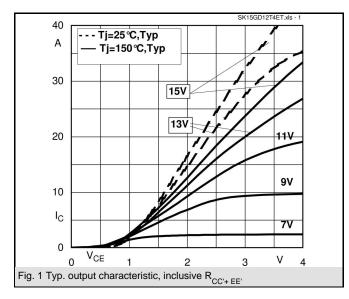
• V<sub>CE.sat</sub> , V<sub>F</sub> = chip level value

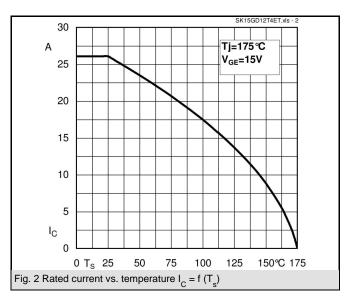
Characteristics							
Symbol	Conditions		min.	typ.	max.	Units	
Inverse D	iode						
$V_F = V_{EC}$	I <sub>Fnom</sub> = 15 A; V <sub>GE</sub> = 0 V	T <sub>j</sub> = 25 °C <sub>chiplev.</sub>		2,38	2,71	V	
		$T_j = 150  ^{\circ}C_{chiplev.}$		2,44	2,77	V	
$V_{F0}$		T <sub>j</sub> = 25 °C		1,3	1,5	V	
		T <sub>j</sub> = 150 °C		0,9	1,1	V	
r <sub>F</sub>		T <sub>j</sub> = 25 °C		72	80,6	mΩ	
		T <sub>j</sub> = 150 °C		102,7	111,3	mΩ	
I <sub>RRM</sub>	I <sub>F</sub> = 15 A	T <sub>j</sub> = 150 °C		28		Α	
$Q_{rr}$	di/dt = 2750 A/µs			0,3		μC	
E <sub>rr</sub>	V <sub>CC</sub> = 600V			0,82		mJ	
$R_{th(j-s)D}$	per diode			2,34		K/W	
M <sub>s</sub>	to heat sink		2,25		2,5	Nm	
w				30		g	
Temperature sensor							
R <sub>100</sub>	$T_s$ =100°C ( $R_{25}$ =5kΩ)			493±5%		Ω	

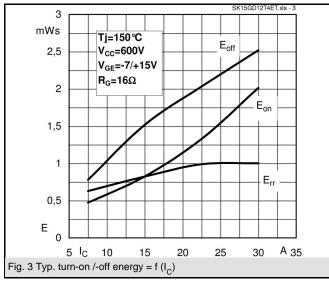
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

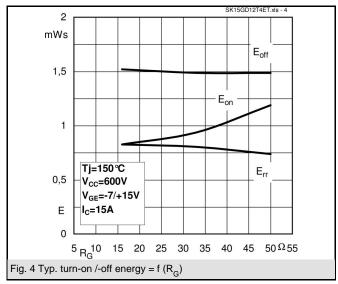
\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

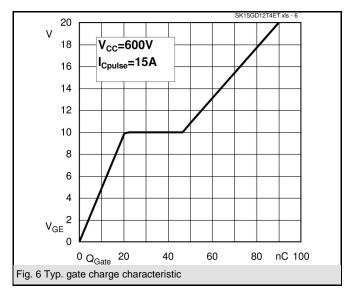


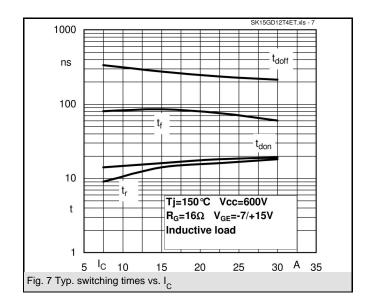


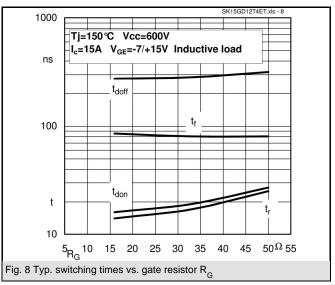


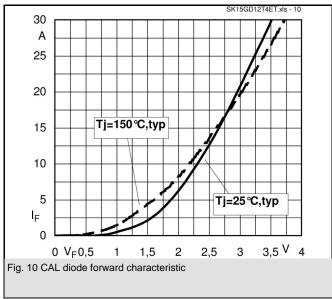












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